Erratum: Characterization by Synchrotron-Radiation X-Ray Photoelectron Spectroscopy of NO Adsorption on Rh

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Figures 3 and 4 in the original article [1] were inappropriately displayed. Correct figures are shown below. “Table I” and “Table 3” that appear in the text on p. 39 in Ref. 1 should be replaced by “Table I” and “Table III”, respectively.

The publisher found that they occurred during the production process. None of the corrections change any discussion and conclusions of the article.

Figure 3: Analysis of deconvolved Rh 3d spectrum of sample (a) before exposure to NO.

References

[1] Y. Koda, H. Sumida, S. Ogawa, C. Tsukada, and H. Namatame, *e-J. Surf. Sci. Nanotechnol.* **16**, 36 (2018).

Figure 4: XPS N 1s spectrum of sample (a) before exposure to NO.

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